

EDC 01 | DAMAGE TO CONDUCTORS

BSEN 60669-1, Clause 12.2.5 / BS 5733, Clause 14.2.5



SECOM

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Our equipment Damage to Conductors 2014 was designed and manufactured to perform the test specified in many standards (IRAM 60884-1, BSEN 60669-1, BS 5733) to the damage to conductors.

Our Damage to Conductor Test Apparatus is fully automated, controlled by microcontroller.

You only should set:

- The time test.

Making the test:

- Place the sample in the test sample holder support.
- Place the wire in the sample and pass it through the hole in the plate assay.
- Place the corresponding weight (or the set of weights) to reach the required weight).
- Turn on the equipment.
- Go to the screen test and press the START key to start the test.
- Adjust the speed with the knob.
- Press PAGE key if you want to reset the lap counter and time.
- The machine automatically stops when it reaches the time set on the equipment test.

Technical characteristics

- Speed regulation: 5 to 18 rpm.
- Indicators:
 - RPM.
 - Time Test.
 - Laps counter.
- Weights: 300grs to 9.1Kg.
- Acrylic walls for safety.
- Dimensions:
 - Height: 450mm.
 - Width: 450mm.
 - Depth: 1150mm. approx.
- Power Supply: 220Vca 50Hz.
- Weight: 38 Kg (aprox.)
- According to: IRAM-NM 244.
- According to: IEC 62230.

SECOM reserves the right to change the specifications or design without prior notice.



Punta del Indio N° 7411 (Camino Viejo a Soldini al 3790)
phone. +54 341 3080258 | contacto@secom.com.ar
www.secom.com.ar